

Static sensitive device

Current part - Recommended for new designs

Op. Temp Range	Frequency Stability (PPM)					
	±0.5	±1.0	±1.5	±2.0	±2.5	±3.0
0°C to +50°C	✓	✓	✓	✓	✓	✓
-10°C to +60°C	Δ	✓	✓	✓	✓	✓
-20°C to +70°C	✗	✓	✓	✓	✓	✓
-30°C to +75°C	✗	✓	✓	✓	✓	✓
-40°C to +85°C	✗	Δ	Δ	✓	✓	✓

Δ= Contact AEL

Storage Temp.	-55°C to +125°C
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Supply Voltage	Option Code
+3.3V DC	3
+2.8V DC	28
+2.5V DC	25
+1.8V DC	18

Marking & Specification Code Format

Type	Voltage Code	Temp Range/Stability Options	WWYY
T***	3,28,25 or 18	See table above	1611

Parameter	Condition	Value				
Available Frequency Range		4.00 - 54.00 MHz				
Initial Calibration		± 2.0 PPM				
Frequency Stability	vs Temperature	± 0.5 PPM to ± 3.0 PPM (To be specified)				
	vs Ageing	±1PPM (1st Year)				
	vs Voltage Change	±0.3PPM for ±5% Voltage change				
	vs Load Change	±0.3PPM for ±10% load change				
	vs Reflow	±1PPM after 1 reflow measured after 24hours				
Output Voltage	Peak to Peak	TTL/CMOS				
Input Current		+3.3V DC	+2.8V DC	+2.5V DC	+1.8V DC	
	4.00 - 10.00 MHz	4.0mA	3.4mA	3.1mA	3.1mA	
	10.01 - 20.00 MHz	4.8mA	4.1mA	3.7mA	3.7mA	
	20.01 - 30.00 MHz	5.5mA	4.7mA	4.2mA	4.2mA	
	30.01 - 40.00 MHz	6.0mA	5.2mA	4.6mA	4.6mA	
	40.01 - 54.00 MHz	7.0mA	6.0mA	5.5mA	5.5mA	
Output Load	Logic High "1"	90% VDD Min.				
	Logic Low "0"	10% VDD Max.				
Duty Cycle	at 50% V _{DD}	50% ±10%				
Rise/Fall Time	0.1VDD to 0.9VDD	10nS Max from 20% to 80% of waveform				
Start Up Time	0V to V _{DD}	10mS Max.				
Output Load	HCMOS Load	15pF Max.				
SSB Phase Noise at 25°C	Offset	10Hz	100Hz	1kHz	10kHz	100kHz
	10.000000 MHz	-115dBc/Hz	-135dBc/Hz	-148dBc/Hz	-152dBc/Hz	-155dBc/Hz
Jitter	Period jitter RMS	3ps Typ.				
Ageing	per Year at 25°C	±1PPM Max.				

Dimensions (mm)

